

Notice of References Cited	Application/Control No. 10/789,280	Applicant(s)/Patent Under Reexamination WASHINGTON ET AL.	
	Examiner Steven S. Paik	Art Unit 2876	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,786,354 B2	09-2004	Black et al.	221/6
	B	US-5,141,127 A	08-1992	Graef et al.	221/4
	C	US-6,540,136 B1	04-2003	Ross, Ian	235/379
	D	US-4,917,792	04-1990	Murakami, Hiroyoshi	209/534
	E	US-6,196,457 B1	03-2001	Patterson, David L.	235/379
	F	US-6,196,464 B1	03-2001	Patterson et al.	235/477
	G	US-6,724,303 B2	04-2004	McGunn et al.	340/521
	H	US-4,992,648	02-1991	Hutchison, Brian G.	235/379
	I	US-4,659,008	04-1987	Howett et al.	232/43.3
	J	US-5,563,393	10-1996	Coutts, Michael G.	235/379
	K	US-6,065,672	05-2000	Haycock, Richard Glen	235/379
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	EP 1126120 A1	08-2001	European Patent	AMBROSINI, SERGIO	E05G 01/00
	O	GB 2202066 A	09-1988	United Kingdom	KUEI et al.	G08B 13/22
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.